

**Search Notes**

Application/Control No.

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Examiner

Brian D. Nguyen

Applicant(s)/Patent under  
Reexamination

CHO ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	468,455, 335,342, 465,252	9/12/2005	NB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Text	search	1/22/2007	BN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	9/12/2005	NB
East	3/30/2006	BN
East	4/13/2006	BN
East	4/15/2006	BN
East	1/22/2007	BN